

- Spektrofotometry - PEAK Instruments Inc.



E-1000 Series



Introduction

- Smooth appearance design
- Ingenious color assortment
- White backlit LCD screen
- Oval buttons
- · Easy parameter setting and microprocessor make the operation more convenient

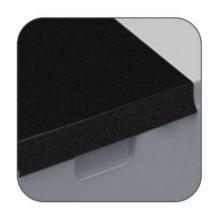
Main Features

- 70*40 mm backlit LCD screen can show complete parameters like T,A,C,K.
- Calibrate 0%A and 100%T automatically.
- Large sample compartment can hold various cells from 5mm to 100mm and meet different test requirements.
- RS232 output port and professional analysis software UV-PRO1.0 with the functions of quantitative analysis.
- Automatic lamp switches and manual wavelength setting.
- · Save and read out the test data and values of K and B.

E-1000 Series







Specifications

| MODEL | E-1000V | E-1000UV | | |
|--------------------------------|-----------------------------------|---------------------------------|--|--|
| Display | 70*40 | mm backlit LCD | | |
| Wavelength Range | 320 - 1020nm | 190 - 1020nm | | |
| Slit Width | 4nm | | | |
| Wavelength Accuracy | ±2nm | | | |
| Wavelength Repeatability | ≤1nm | | | |
| Photometric Accuracy | 0.5%T | | | |
| Photometric Repeatability | 0.2%T | | | |
| Stray Light | ≤0.15%T@360nm | | | |
| Stability | 0.002A@500nm | | | |
| Output Port | RS232 | | | |
| Light Source | Tungsten Halogen Lamp | Tungsten Halogen/Deuterium Lamp | | |
| Power Requirements | 110-220V, 50-60Hz | | | |
| Photometric Range | 0-200%T, -0.3-3A,0-9999C(0-9999F) | | | |
| Shipping Dimensions And Weight | 530*460*320mm, 9 kg | | | |

C-7000 Series



Introduction

Steady, modern and elegant appearance design. Adopt the newest microcomputer technology and electronic control system. Optimized optical system and structure can both extend new functions and ensure the accuracy, stability and durability.

Main Features

- 7 inch TFT screen and long life, more comfortable and sensitive silicone buttons.
- Support USB storage and different data formats such as Excel, txt and image (PC software). Users can output
 test data to flash memory, open and edit them on computers directly without any auxiliary software.
- Standard RS232, USB(A) and USB(B) port.
- High-efficiency holographic grating of 1200 lines/mm and low stray light.
- The equipment has long-life socket type tungsten-halogen and deuterium lamps, can switch the lamps
 according to test needs and record its working time automatically. Socket type lamps make the replacement
 much easier.
- Excellent silicon photodiode can guarantee the equipment is highly sensitive and stable.
- Huge sample chamber and various accessories can meet all kinds of needs.
- Can be connected to printer directly and output test charts and data.
- Powerful PC software can realize scanning function.

C-7000 Series

Specifications

| MODEL | C-7000V | C-7000UV | | | |
|--------------------------------|---|---------------------------------|--|--|--|
| Display | 7-inch TFT screen | | | | |
| Wavelength Range | 320 - 1100nm | 190 - 1100nm | | | |
| Slit Width | 2nm 2nm | | | | |
| Wavelength Accuracy | ±0.3nm | ±0.3nm | | | |
| Wavelength Repeatability | ≤0.2nm | | | | |
| Photometric Accuracy | 0.3%T (0-100%T), ±0.002A(0-0.5A), ±0.004A(0.5-1A) | | | | |
| Photometric Repeatability | ≤0.15%T (0-100%T), 0.001A(0-0.5A), 0.002A(0.5-1A) | | | | |
| Stray Light | ≤0.05%T@220 nm, 360nm | | | | |
| Stability | ±0.002 A/h@500nm | | | | |
| Baseline Flatness | ±0.002A | ±0.002A | | | |
| Noise | ±0.0005A | | | | |
| Working Mode | T,A,C,E | | | | |
| Wavelength Setting | Automatic | | | | |
| Photometric Range | 0-200%T, -0.3 - 3A, 0-9999C(0-9999F) | | | | |
| Detector | Solid Silicon Photodiode | | | | |
| Software | Optional with scanning function | | | | |
| Printer | Optional | | | | |
| Keypad | Silicone Buttons | | | | |
| Data Port | USB | | | | |
| Light Source | Tungsten Halogen Lamp | Tungsten Halogen/Deuterium Lamp | | | |
| Power Requirements | 110-220V, 50-60Hz | | | | |
| Humidity Range | Less than 85% | | | | |
| Shipping Dimensions and Weight | 770*630*340mm, 27kg | | | | |

C-7100/7200 Series



Steady, modern and elegant appearance design. Adopt the newest microcomputer technology and electronic control system. Optimized optical system and structure can both extend new functions and ensure the accuracy, stability and durability.

Main Features

- 7 inch TFT screen and long life, more comfortable and sensitive silicone buttons. The instrument can show various scanning curves and charts for users to complete various tests without computers.
- Support USB storage and different data formats such as Excel, txt and image (PC software). Users can output
 test data to flash memory, open and edit them on computers directly without any auxiliary software.
- Advanced hardware and 32-bit Cortex_M3 processor with the clock speed 120MHz. The equipment can store 5000 pieces of data and 500 curves.
- · High-efficiency holographic grating of 1200 lines/mm and low stray light.
- The equipment has long-life socket type tungsten-halogen and deuterium lamps which can work up to 2000 hours, can switch the lamps according to test needs and record its working time automatically. Socket type lamps make the replacement much easier.
- Excellent silicon photodiode can guarantee the equipment is highly sensitive and stable.
- Huge sample chamber and various accessories can meet all kinds of needs.
- Can be connected to printer directly and output test charts and data.
- Powerful PC software.
- Standard RS232, USB(A) and USB(B) port.

C-7100/7200 Series

Specifications

| MODEL | C-7100 | C-7100S | C-7100A | C-7200 | C-7200S | C-7200A |
|--------------------------------|--|----------------|-----------------------|-------------|----------------|-----------------------|
| Display | 7 inch TFT | | | | 7 inch TFT | |
| Keyboard Control | SIIICODE DUIOUS | | | | | Silicone Buttons |
| | Single Beam Double | | | Double Bear | | |
| Optical System | Holographic grating, 1200 lines/mm | | | | | |
| Slit Width | 2nm | 1nm | 0.5,1,2, 4nm | 2nm | 1nm | 0.5,1,2, 4nm |
| Wavelength Range | 190 - 1100nm | | | | | |
| Wavelength Accuracy | ±0.3nm | | | | | |
| Wavelength Repeatability | ≤0.2nm | | | | | |
| Photometric Accuracy | 0.2%T (0-100%T), ±0.002A(0-0.5A), ±0.004A(0.5-1A) | | | | | |
| Photometric Repeatability | ≤0.15%T (0-100%T), 0.001A(0-0.5A), 0.002A (0.5-1A) | | | | | |
| Stray Light | ≤0.03%T@220nm, 360nm | | | | | |
| Stability | ±0.002A/h@500nm | | | | | |
| Photometric Range | 0-200%T, -0.3-3.0A, 0-9999C(0-9999F) | | | | | |
| Baseline Flatness | ±0.002A (200-1000nm) | | | | | |
| Noise | 0.0003A@500nm | | | | | |
| Working Mode | T,A,C,E | | | | | |
| Wavelength Setting | Automatic | | | | | |
| Scanning Speed | Low, Medium, High (up to 3000nm/min) | | | | | |
| Detector | Solid Silicon Photodiode | | | | | |
| Light Source | Tungsten Halogen/Deuterium Lamp | | | | | |
| Data Output | RS232 Serial, USB Drive, USB HOST | | | | | |
| Processor | Cortex_M3, 120Mhz | | | | | |
| Power Requirements | AC 110-220V 50-60Hz | | | | | |
| Shipping Dimensions and Weight | | 0*340mm 7kg | 880*690*530mm 45kg | |)*340mm 7kg | 880*690*530mm 45kg |

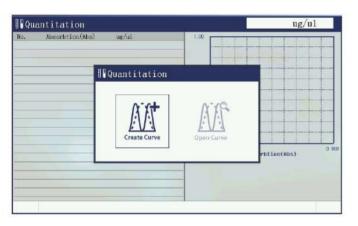
UI Design (Silicone Buttons)



There are three test modes.

Absorbance, transmittance and energy.

Photometry



Quantitative Measurement

To test sample solution concentration, you can choose different methods like coefficient, standard curve, linearity, linearity through zero and quadratic. Up to 15 standard samples can be used to create a curve. Advanced arithmetic makes curvilinear regression more precise and test data more accurate.

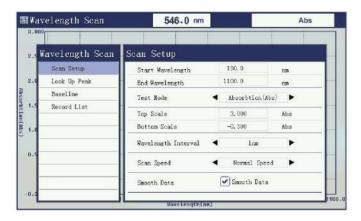


Kinetics Measurement(Time Scanning)

To test the sample chemical reaction process by fixed time scanning the sample solution with fixed wavelength.

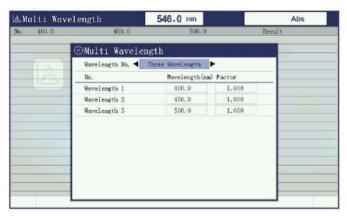
The equipment can calculate its changing rate after entering the corresponding parameters.

UI Design (Silicone Buttons)



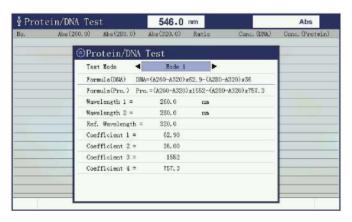
To test sample solution absorbance peak, can scan the sample characteristic curve of any wavelength range between 190 and 1100nm. You can look up the peak value on the standalone device.

Wavelength Scanning(Qualitative Test)



It is much more convenient for users to test the absorbance of several wavelengths for the same sample solution, which is much simpler than single wavelength testing.

Multi Wavelength Measurement



There are two test modes and formulas based on absorbance ratio 260nm/280nm or 230nm with substracted absorbance at 320nm.

DNA/Protein Measurement

Comparison Table

| | UV/Vis. | Optical System | Display | Slit Width | Wavelength Accuracy | Wavelength Repeatabiltiy | Stray Light | Light Source | Page | | |
|----------|---------|-------------------|---------------|--------------|------------------------|-----------------------------|-------------------------|-------------------------------------|--------|------------|------|
| E-1000V | Vis. | Single | 70*40mm LCD | 4 nm | ±2 nm | ≤1 nm | ≤0,15%T@360nm | Tungsten Halogen Lamp | 1/2 | | |
| E-1000UV | UV | Orrigic | 70 40Hill EGD | 7 11111 | ±21III | 311111 | 20,13 //1@3001111 | Tungsten Halogen /Deuterium Lamp | .,,, | | |
| C-7000V | Vis. | | | | | | | Tungsten Halogen Lamp | 2/4 | | |
| C-7000UV | Single | | | 2 nm | nm | | | | 3/4 | | |
| C-7100 | | | | | | | ≤0.05%T @220nm,360nm | | | | |
| C-7100S | | | | 1 nm | | | | Tungsten Halogen /Deuterium Lamp | 5/8 | | |
| C-7100A | UV | 7 | 7 inch FTF | 0.5,1,2,4nm | 2,4nm ±0.3 nm ≤0.2 nm | ≤0.2 nm | | | | | |
| C-7200 | | Double | | 2 nm | | 50.211111 | ≤0.03%T @220nm,360nm | | | | |
| C-7200S | | | Double | 1 nm | | | | | | | |
| C-7200A | | | | 0.5,1,2,4 nm | | | | | | | |
| X-8200 | | | 7 in th FTF | 2 nm | | | | | | | |
| X-8200S | | | | | 7 inch FTF | 1 nm | ±0.6 nm | ≤0.2 nm | ≤0.1%T | Xenon Lamp | 9/10 |
| X-8200T | UV | Double | | 2 nm | ±0.6 mm | 50.2 1111 | @220nm,360nm | Zenon Lamp | 9/10 | | |
| X-8200TS | | | Touch Screen | 1 nm | | | | | | | |
| T-9100 | Single | | | 2 nm | ±0.3 nm | ≤0.2 nm | | | | | |
| T-9200 | 1.07 | | 20.51111 | 30.2 IIII | ≤0.05%T | Tungsten Halogen | | | | | |
| T-9200S | UV | Double | Todoli Goleen | 1 nm | ±0.3 nm | ≤0.2 nm | @220nm,360nm | /Deuterium Lamp | 11/14 | | |
| T-9200A | | | | 0.5,1,2,4,nm | ±0.3 IIII | 20.2 HH | | | | | |



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